

<b>Notice of References Cited</b>	Application/Control No. 10/650,917	Applicant(s)/Patent Under Reexamination TANADA ET AL.	
	Examiner Diem Tran	Art Unit 3748	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,220,018	04-2001	Yamanashi et al.	60/285
	B	US-6,230,489	05-2001	Tsuzuki et al.	60/299
	C	US-5,538,697	07-1996	Abe et al.	422/171
	D	US-6,029,441	02-2000	Mizuno et al.	60/274
	E	US-5,887,422	03-1999	Abe et al.	60/274
	F	US-6,185,933	02-2001	Tsuzuki et al.	60/285
	G	US-6,681,567	01-2004	Yasui et al.	60/297
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.